

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10567538	JEONG, EUI RIM
Examiner	Art Unit	
MICHAEL R NEFF	2611	

SEARCHED

Class	Subclass	Date	Examiner
370	208, 355	10/12/2009	MRN
375	302, 295	10/12/2009	MRN

SEARCH NOTES

Search Notes	Date	Examiner
Inventor/Double patenting search performed	10/12/2009	MRN
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INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/MICHAEL R NEFF/
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